

Search Notes

Application/Control No.

10/822,772

Examiner

Jinhee J. Lee

Applicant(s)/Patent under
Reexamination

PARK ET AL.

Art Unit

2174

SEARCHED

Class	Subclass	Date	Examiner
715	719-726, 729, 730	6/22/2007	LEE

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
715	as above	6/22/2007	LEE

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East text search attached	6/22/2007	LEE